

Application/Control No.
10/677,075
Examiner

Nam V. Nguyen

Applicant(s)/Patent under Reexamination

KONNO, TAKESHI

Art Unit

2635

SEARCHED				
Class	Subclass	Date	Examiner	
340	5.61	9/22/2005	NN	
340	5.6+	9/22/2005	NN	
340	5.7+	9/22/2005	NN	
340	10.1	9/22/2005	NN	
340	10.3+	9/22/2005	NN	
340	10.4+	9/22/2005	NN	
340	426	9/22/2005	NN	
381	86	9/22/2005	NN	
343	713	9/22/2005	NN	
343	711	9/22/2005	NN	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Search East: USPAT; US-PUB; EPO; JPO; Derwent.	9/22/2005	NN
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